

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 218428US0		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Ralf FINK, et al.			
				FILING DATE HEREWITH		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
SMC ↑ ↓	AA	5,264,533	11/23/93	Gerd REHMER, et al.	2		
	AB	5,389,699	02/14/95	Gerd REHMER, et al.			
	AC	5,128,286	07/07/92	Osamu FUNAYAMA, et al.			
	AD	5,223,645	06/29/93	Juergen BARWICH, et al.			
	AE	5,248,805	09/28/93	Andreas BOETTCHER, et al.			
SMC	AF	4,042,768	08/16/77	Ernst-Willi MUELLER, et al.			
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
SMC ↑ ↓	AO	EP 0 103 407	08/11/83	EUROPE			
	AP	EP 0 330 272	02/17/89	EUROPE			
	AQ	WO 96/26221	08/29/96	WIPO			
	AR	EP 0 346 734	06/06/89	EUROPE (Corresponding U.S. Patents 5,264,533 and 5,389,699)		X	
	AS	EP 0 377 199	12/27/89	EUROPE (Corresponding U.S. Patent 5,128,286)		X	
SMC	AT	DE 40,37 079	11/22/90	GERMANY (Corresponding U.S. Patent 5,223,645)		X	
	AU	DE 38 44 444	12/31/88	GERMANY (Corresponding U.S. Patent 5,248,805)		X	
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>S. J. Miller</i>					Date Considered <i>7/26/03</i>		
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

 1997 U.S. PTO
 10/056116
 01/28/02

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SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
218428US0SERIAL NO.
10/056,116

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Ralf FINK, et al.

FILING DATE

January 28, 2002

GROUP

1713

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO
SMC	AN	320 104	01/27/75	AUSTRIA		X
	AO	1 078 942	08/09/67	GREAT BRITAIN		
A	AP	1 280 631	07/05/72	GREAT BRITAIN		
	AQ	1 322 721	07/11/73	GREAT BRITAIN		
	AR	1 569 922	07/09/70	GERMANY		X
	AS	2 039 079	02/10/72	GERMANY		X
	AT	2 236 575	02/07/74	GERMANY		X
	AU	0 155 557	09/25/85	EUROPE		X
SMC	AV	44 32 876	04/18/96	GERMANY		X

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

SMC	AW	Patent Abstracts of Japan, JP 58 067776, April 22, 1983
	AX	
	AY	
	AZ	

Examiner

SMC MLL

Date Considered

7/26/03

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